

International Conference on , Volume: 2 , 21-24 April 1997
Pages:867 - 870 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(324 KB\)\]](#) IEEE CNF

5 Approaches to RF interference suppression for VHF/UHF synthetic aperture radar

Lord, R.T.; Inggs, M.R.;

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6 HDTV/CDTV compatible coding with recursive estimation

Tihao Chiang; Anastassiou, D.;

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Pages:248 - 252 vol.1

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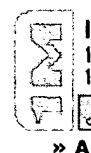
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Magnetics, IEEE Transactions on , Volume: 40 , Issue: 4 , July 2004

Pages:3105 - 3107

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